BUK9840-55

GENERAL DESCRIPTION

N-channel enhancement mode logic level field-effect power transistor in a plastic envelope suitable for surface mounting. The device features very low on-state resistance and has integral zener diodes giving ESD protection. It is intended for use in automotive and general purpose switching applications.

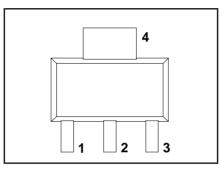
QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{DS} I _D P _{tot} T _j R _{DS(ON)}	Drain-source voltage Drain current Total power dissipation Junction temperature Drain-source on-state resistance $V_{GS} = 5 \text{ V}$	55 10.7 1.8 150 40	V A W °C mΩ

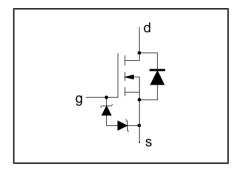
PINNING - SOT223

PIN	DESCRIPTION	
1	gate	
2	drain	
3	source	
4	drain (tab)	

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DS}	Drain-source voltage	-	-	55	V
V _{DGR}	Drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	55	V
$V_{DGR} \pm V_{GS}$	Gate-source voltage	- "	-	10	V
I _D	Drain current (DC)	$T_{sp} = 25 ^{\circ}C$	-	10.7	Α
l _D	Drain current (DC)	On PCB in Fig.19	-	5	Α
	, ,	$T_{amb} = 25 ^{\circ}C$			
I _D	Drain current (DC)	On PCB in Fig.19	-	3.1	Α
	, ,	$T_{amb} = 100 ^{\circ}C$			
I _{DM}	Drain current (pulse peak value)	$T_{sp} = 25 ^{\circ}C$	-	40	Α
P _{tot}	Total power dissipation	$T_{sp} = 25 \degree C$ $T_{sp} = 25 \degree C$	-	8.3	W
P _{tot}	Total power dissipation	On PCB in Fig.19	-	1.8	W
	· · ·	$T_{amb} = 25 ^{\circ}C$			
T_{stg} , T_{j}	Storage & operating temperature	-	- 55	150	°C

ESD LIMITING VALUE

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _C	Electrostatic discharge capacitor voltage	Human body model (100 pF, 1.5 kΩ)	-	2	kV

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THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
R _{th j-sp}	From junction to solder point	Mounted on any PCB	12	15	K/W
R _{th j-amb}	From junction to ambient	Mounted on PCB of Fig.18	-	70	K/W

STATIC CHARACTERISTICS

T_i= 25°C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)DSS}	Drain-source breakdown	$V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}$	55	-	-	V
	voltage	$T_i = -55^{\circ}C$	50	-	-	V
$V_{GS(TO)}$	Gate threshold voltage	$V_{DS} = V_{GS}$; $I_D = 1 \text{ mA}$	1.0	1.5	2.0	V
()		$T_j = 150^{\circ}C$ $T_i = -55^{\circ}C$	0.6	-	-	V
		$T_i = -55^{\circ}C$	-	-	2.3	V
I _{DSS}	Zero gate voltage drain current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V};$	-	0.05	10	μΑ
		$T_i = 150^{\circ}C$	-	-	100	μA
I _{GSS}	Gate source leakage current	$V_{GS} = \pm 5 \text{ V}$	-	0.02	1	μΑ
		$T_i = 150^{\circ}C$	-	-	5	μA
±V _{(BR)GSS}	Gate source breakdown voltage	$I_{G} = \pm 1 \text{ mA}$	10	-	-	·V
R _{DS(ON)}	Drain-source on-state	$V_{GS} = 5 \text{ V}; I_D = 5 \text{ A}$	-	30	40	$m\Omega$
23(311)	resistance	$T_j = 150^{\circ}C$	-	-	74	m $Ω$

DYNAMIC CHARACTERISTICS

 $T_{mb} = 25$ °C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
g _{fs}	Forward transconductance	$V_{DS} = 25 \text{ V}; I_D = 5 \text{ A}; T_j = 25^{\circ}\text{C}$	11	19	1	S
$egin{array}{c} C_{\text{iss}} \ C_{\text{oss}} \ C_{\text{rss}} \end{array}$	Input capacitance Output capacitance Feedback capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$		1050 205 110	1400 245 150	pF pF pF
$egin{array}{c} t_{d\ on} \ t_r \ t_{d\ off} \ t_f \end{array}$	Turn-on delay time Turn-on rise time Turn-off delay time Turn-off fall time	$V_{DD} = 30 \text{ V}; I_{D} = 9 \text{ A};$ $V_{GS} = 5 \text{ V}; R_{G} = 10 \Omega;$ $T_{j} = 25^{\circ}\text{C}$		17 65 70 70	25 100 105 105	ns ns ns ns

REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS

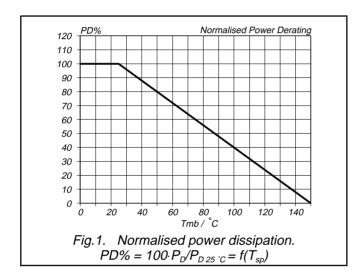
 $T_j = -55$ to 175°C unless otherwise specified

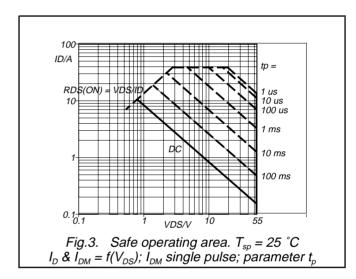
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{DR}	Continuous reverse drain current	$T_{sp} = 25^{\circ}C$	-	-	10.7	Α
$I_{DRM} \ V_{SD}$	Pulsed reverse drain current Diode forward voltage	$T_{sp} = 25^{\circ}C$ $I_F = 5 A; V_{GS} = 0 V$		- 0.85	40 1.1	A V
t _{rr} Q _{rr}	Reverse recovery time Reverse recovery charge	$I_F = 5 \text{ A}; -dI_F/dt = 100 \text{ A/}\mu\text{s};$ $V_{GS} = -10 \text{ V}; V_R = 30 \text{ V}$	-	45 .3		ns μC

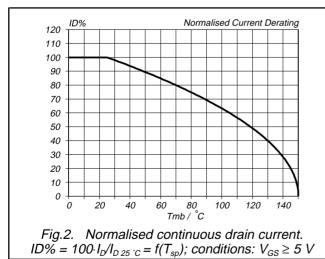
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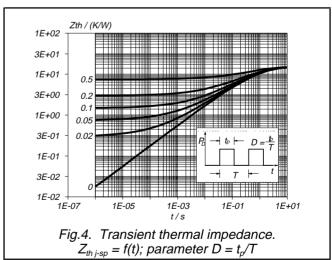
AVALANCHE LIMITING VALUE

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
W _{DSS}		$I_D = 3.6 \text{ A}; V_{DD} \le 25 \text{ V};$ $V_{GS} = 5 \text{ V}; R_{GS} = 50 \Omega; T_{sp} = 25 \text{ °C}$	1	ı	60	mJ

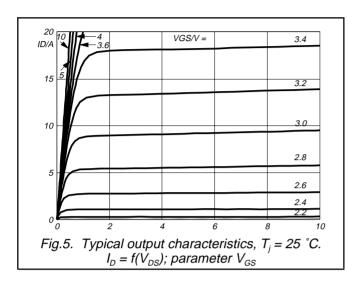


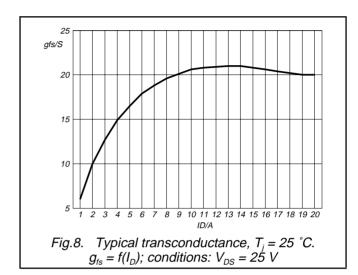




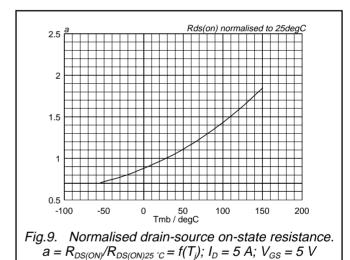


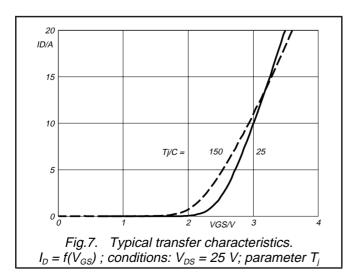
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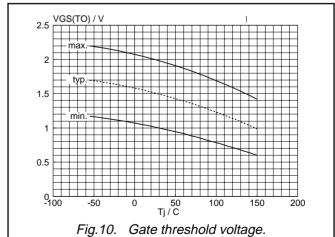




RDS(ON)/mOhm $VGSV = \begin{bmatrix} 3 \\ 3 \end{bmatrix}$ $SO(DS) = \begin{bmatrix} 3 \\ 3 \end{bmatrix}$ $SO(DS) = \begin{bmatrix} 3 \\ 4 \end{bmatrix}$ SO(DS)

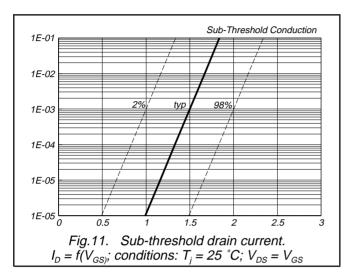


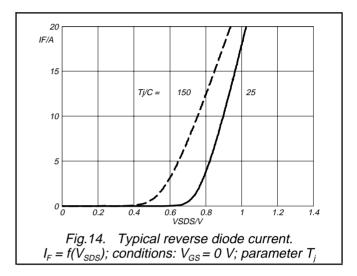


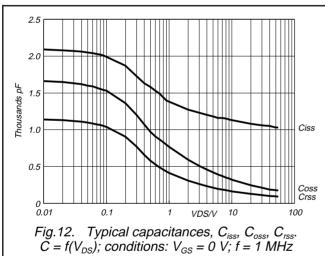


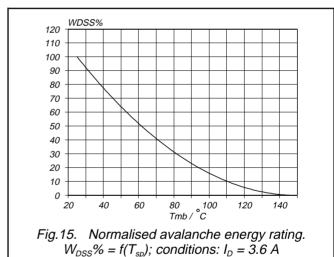
 $V_{GS(TO)} = f(T_j)$; conditions: $I_D = 1$ mA; $V_{DS} = V_{GS}$

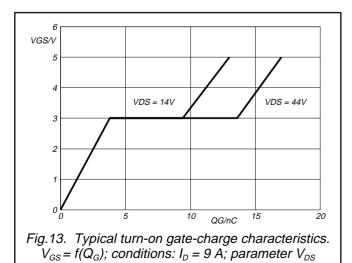
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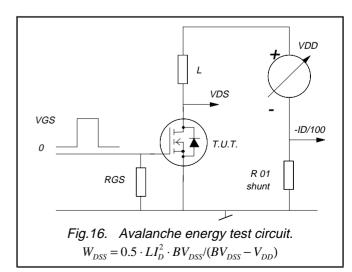




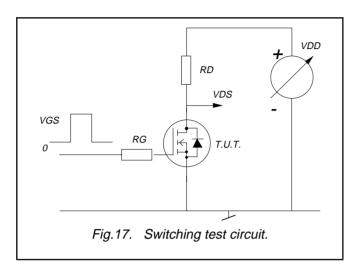






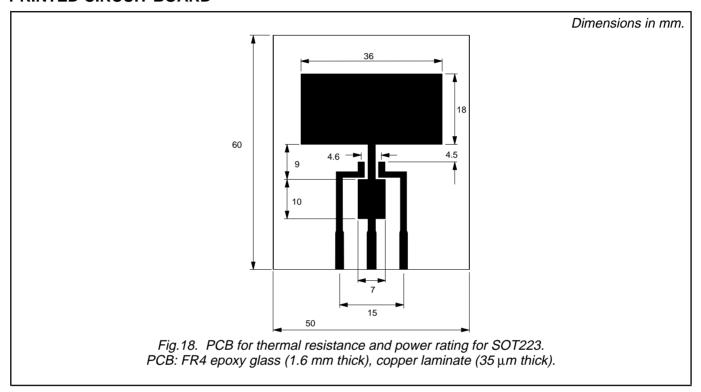


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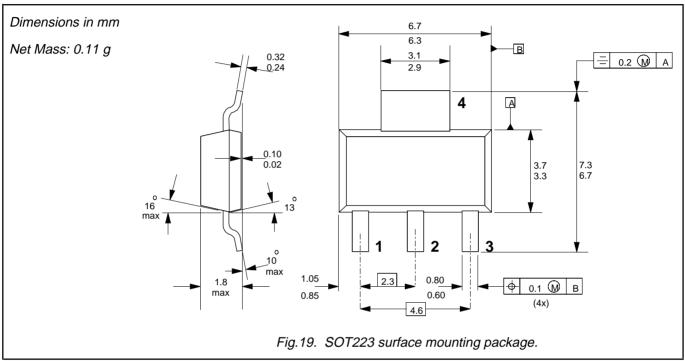
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PRINTED CIRCUIT BOARD



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MECHANICAL DATA



Notes

- 1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
- 2. Refer to surface mounting instructions for SOT223 envelope.
- 3. Epoxy meets UL94 V0 at 1/8".

Philips Semiconductors Product specification

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DEFINITIONS

Data sheet status					
Objective specification	This data sheet contains target or goal specifications for product development.				
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.				
Product specification	This data sheet contains final product specifications.				
Limiting values					

Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

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